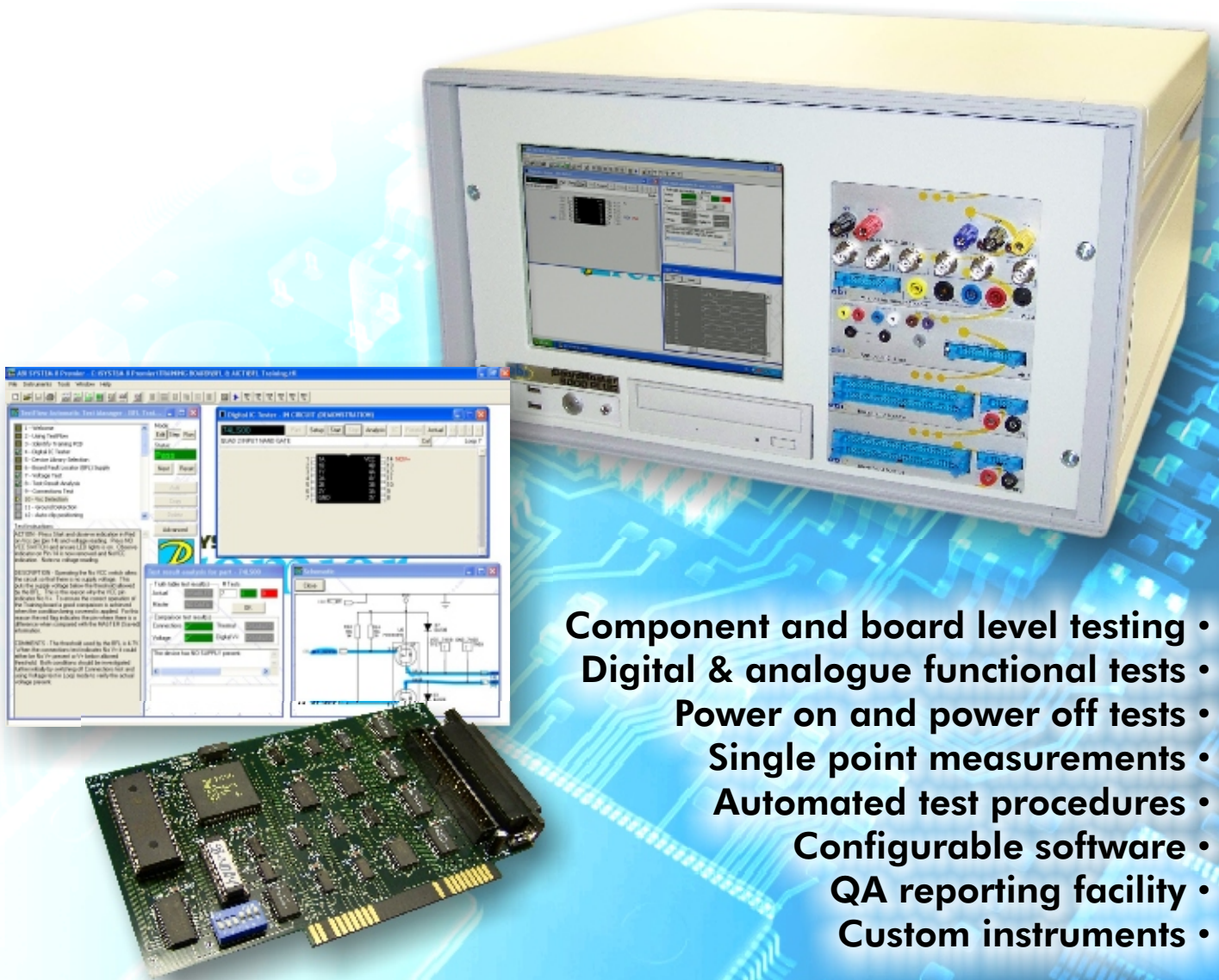


# THE ULTIMATE IN DIAGNOSTICS TOOLS



- Component and board level testing
- Digital & analogue functional tests
- Power on and power off tests
- Single point measurements
- Automated test procedures
- Configurable software
- QA reporting facility
- Custom instruments

## BoardMaster 8000 PLUS

### Universal Diagnostic System

The ABI BoardMaster 8000 PLUS is a uniquely versatile, self-contained and easy-to-use test system. It offers the most comprehensive set of test instruments for fault-finding on almost any kind of PCB.

Whether your task is design verification, production test, semiconductor device testing, production repair or general maintenance, and whether your boards are analogue, digital or both, the BoardMaster 8000 PLUS provides the ultimate in diagnostic tools.



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# The perfect solution for all your test requirements...

Today's rapidly changing, dynamic and progressive electronics industry presents multiple problems to engineers, whether they are working in design, production, test or fault-finding. Electronic circuits are becoming faster, smaller, cheaper and more complex. Cost-effective test and repair is also becoming more difficult to achieve. As a result, you are making ever increasing demands on your test equipment to keep pace with the challenges presented by this explosion of technology. If you recognise the problems, you are half way to finding the solution.

Even though technology marches relentlessly on, the basic nature of faults remains the same. ICs still fail, diodes still become open circuit, capacitors still become short circuit. A solder bridge today is the same as a solder bridge 10 years ago. But today we must find these faults quicker. "Beyond economical repair" does not mean that the board cannot be repaired, only that it will take too long.

The economics of repair also includes the cost of test equipment. The BoardMaster 8000 PLUS offers cost-effective fault-finding across a wide range of applications. It is an integrated package of high specification instrumentation controlled by sophisticated but easy to use software. The hardware is installed in a rugged transportable case that also contains a high specification, MS Windows™ compatible PC. The BoardMaster 8000 PLUS is a modular system and can therefore be customised for specific applications. The standard configuration offers :

## Board Fault Locator Module (BFL)

The BoardMaster 8000 PLUS is supplied with two Board Fault Locator modules giving 128 test channels for a variety of test methods. These provide comprehensive fault diagnosis capability and include functional testing of digital ICs (in-circuit / out-of-circuit), IC connections status and voltage acquisition together with a V-I Curve function which allows testing of components with no need to apply power to the board.



## Analogue IC Tester Module (AICT)

The Analogue IC Tester allows in-circuit functional testing of analogue ICs and discrete components. All common analogue devices can be tested as they are configured on the PCB, without programming or the need to refer to circuit diagrams. The AICT also includes a fully configurable V-I Tester for detection of faults on un-powered boards through clear and easy to understand graphical results.



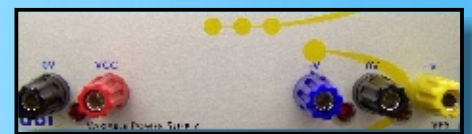
## Multiple Instrument Station Module (MIS)

The Multiple Instrument Station provides no less than 8 high specification test and measurement instruments in one compact module. Ideal for design, education or for general purpose workbench use, the MIS offers a Frequency Counter, Digital Storage Oscilloscope, Function Generator, Digital Floating Multimeter, Auxiliary PSU and Universal I/O. For optimised utilisation, standard instruments can be customised or new ones can be designed to suit applications.



## Variable Power Supply Module (VPS)

The Variable Power Supply provides the necessary supply voltages to the unit under test. The three outputs are variable in voltage and offer over voltage protection or current limitation.

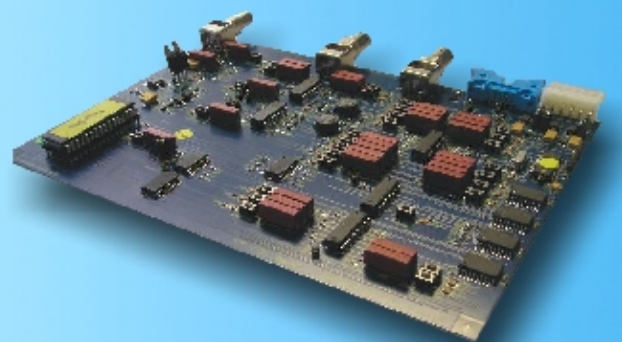


## Training Package

It is common knowledge that a trained operator works more efficiently than a novice. At ABI Electronics, we also understand that, in order to get the best out of your equipment, it is crucial to be aware of all its capabilities. With that attitude in mind, ABI Electronics has developed a complete training package for new and advanced users.

A training PCB was specially designed as a platform for the BoardMaster 8000 PLUS. Through PIC-controlled fault conditions, operators approach digital and analogue electronics principles and gain knowledge of repair techniques. A complete guide is also provided in the form of a TestFlow with detailed instructions and explanations.

The training package is widely used in the industry as it allows new users to train on their own and at their own pace, thus freeing advanced users for other tasks. It is also part of many educational courses in universities and technical colleges around the world.



# Standard Accessories

The BoardMaster 8000 PLUS is supplied with a comprehensive range of test clips, test cables and probes for all the test instruments.

## Board Fault Locator Cable Set

- 1 x 64 way test cable
- 1 x 64 way split test cable
- 1 x BDO cable assembly
- 1 x short locator cable assembly
- 1 x ground clip
- 1 x PSU lead set
- 1 x V-I probe assembly

## Additional Board Fault Locator Cable Set

- 1 x 64 way test cable
- 1 x 64 way split test cable
- 1 x BDO cable assembly
- 1 x ground clip
- 1 x PSU lead set
- 1 x V-I probe assembly

## Multiple Instrument Station Cable and Probe Set

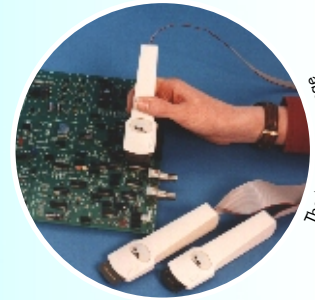
- 2 x DSO probes
- 1 x yellow probe and cable
- 1 x blue probe and cable
- 1 x black probe and cable
- 1 x universal I/O cable (not terminated)

## Analogue IC Test Cable Set

- 1 x 24 way test cable
- 1 x 24 pin test clip
- 1 x yellow probe and cable
- 1 x blue probe and cable
- 2 x pulse leads
- 2 x ground leads
- 3 x discrete leads
- 1 x SMT tweezer set and adapters.

## DIL Test Clips (0.3" gauge - 8, 16, 20, 24 pin, 0.6" gauge - 24, 40 pin)

Automatic out-of-circuit adapter  
40 pin ZIF socket for out-of circuit testing of ICs. SOIC and PLCC adapters available.



The MultiProbe Range



The PenProbe Range

# Optional Accessories

## MultiProbe Range

0.050" pitch 10 pin (SOIC and PLCC) and 0.100" pitch 8 pin (DIL).

## PenProbe 4-piece Set

Type 1 (3 pin transistors, SOT23 and similar), type 2 (3 pin transistors, TO72 and similar), type 3 (3 pin transistors, TO220 and similar), type 4 (3 pin transistors, TO92 and similar)

## SOIC test clip and cable set

8,14,16 pin narrow and 20, 24, 28 pin wide

## PLCC test clip and cable assembly

20, 28, 44, 52, 68 and 84 pin

## QFP test clip and cable assembly

100, 144, 160, 208 pin



A full range of clips and cables available

# Premier Software

The software SYSTEM 8 Premier is designed for seamless interaction with the hardware whilst still providing state of the art test algorithms. Advanced control to the system is provided through intuitive windows including :

- User access manager
- TestFlow automatic test manager
- Instrument design manager
- Instrument menu manager
- Custom calculator functions
- Flexible data logger

At the heart of SYSTEM 8 Premier is the concept of TestFlow, an approach to testing and fault finding that not only speeds up operation - and thus turnover - but also allows the system to be used by semi-skilled operators.

TestFlow transforms fault finding into a methodical, step by step procedure that reduces the risk of inaccurate measurements by recording all the parameters of a test. Technicians can write a test procedure, or TestFlow, for a particular PCB by setting up each stage of the process and recording the results. They may also include their knowledge of the board through schematics, bitmap images or even notes and instructions to assist with the task. Semi-skilled operators need only follow the instructions on-screen to carry out an extensive test sequence on even the most complicated equipment.

The TestFlow Automatic Test Manager provides automatically documented fault-finding reports by comparing good and bad boards. Test points, test methods, operator instructions and reported results with statistical functions are all available on-screen in an easy to follow format.

With TestFlow, knowledge and experience of a PCB does not belong to only one person; it can be accessed by anyone !

	Board Fault Locator	Analogue IC Tester	Analogue Test Station	Multiple Instrument Station	Variable Power Supply
Channels per instrument (analogue in brackets)	64 <sup>(1)</sup>	(24)	(24)	4+(4)	N/A
Power supplies	5V			5V ±9V	2-7V ±24V
Discrete testing		●			
Analogue impedance test		●	●		
Digital impedance test	●				
Logic supplies	●			●	●
Measurement <sup>(2)</sup>				●	
Short locator	●				
Unknown IC search	●				
Out-of-circuit	● <sup>(3)</sup>				
In-circuit	●	●	●	●	●
Analogue test		●	●		
Digital test	●				
IC functional test	●	●			
Test Generator	●				
PremierLink Software	●	●			

(1) 128 channels with BoardMaster8000+. Upgrade options : 128, 192, 256

(2) DSO, Function Generator, Frequency Counter, Digital Floating Multimeter, Universal I/O

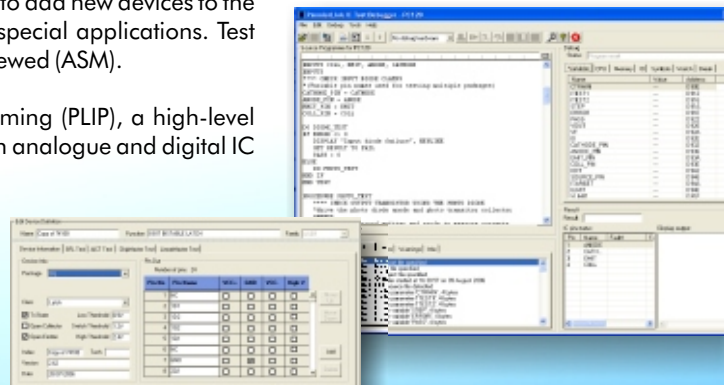
(3) Requires adapter (included)

## PremierLink Software (Optional)

PremierLink is an optional PC based software package that allows users to add new devices to the library, select a variety of tests and create new functional tests to suit special applications. Test routines for devices included in the System8 built-in library can also be viewed (ASM).

New IC functional tests can be created using PremierLink IC Programming (PLIP), a high-level descriptive test programming language optimised for generation of both analogue and digital IC test programmes.

- Library development manager for IC configuration and test selection
- PLIP programming for full generation of new IC functional tests
- Access to test routines for System8 built-in library devices
- Compiler, debugger and active help integrated



## Applications: who uses the BoardMaster 8000 PLUS?

With customers ranging from a manufacturer of flight simulators to an aluminium company, from an IC manufacturer to universities and technical colleges, the BoardMaster 8000 PLUS, and its associated range SYSTEM 8, demonstrates its versatility everyday, in every technical field available and in every corner of the world. Many repair centres are equipped with the BoardMaster to offer the best fault coverage and maintenance capabilities to their wide range of customers including telecommunications, transportation and even consumer goods. Thanks to a strong network of partners, the BoardMaster is also the instrument of choice for many land forces, air force and navy organisations around the globe.

### Advanced applications : high volume and end-of-line testing

The BoardMaster 8000 PLUS is also an excellent solution to set up customised rigs and test stations which aim are to ensure the quality of a large number of PCBs through a test protocol. Some setups, for instance, use the Multiple Instrument Station (MIS) module to acquire a variety of measurements whilst the Board Fault Locator (BFL) module is used to control the multiplexing of test points. Test time is kept to a minimum thanks to the automated test sequences (TestFlows) which are also able to log results for reporting. Contact ABI Electronics to discuss your requirements.

## Specifications for BoardMaster 8000 PLUS

### Digital IC Test

128 test channels (2 x 64 in live comparison mode). 8 bus disable outputs. 2 x 5V/5A power supplies. Truth table (functional), voltage, connections, thermal & V-I tests. Logic trace mode. EPROM verifier. IC Identifier. Adjustable logic thresholds. Auto clip positioning and circuit compensation.

### Analogue IC Test

24 channels plus 3 discrete. Library driven tests for op amps, comparators, optos, transistors, diodes and special function devices. Functional, connections and voltage tests. Auto clip positioning and circuit compensation.

### Digital V-I Test

128 test channels (2 x 64 in live comparison mode). Variable voltage range. Optimised for digital components.

### Analogue V-I Test

24 channels plus 2 probes. Variable frequency, impedance, voltage and waveforms. 2 adjustable pulse outputs. Automatic calibration. V-I, V-T and I-T display. Optional out-of-circuit adapter available.

### Matrix V-I

24 channels with rotating reference. Multi-plot display with single waveform zoom. Mean percentage comparison for each pin with audible and visual indication.

### Graphical Test Generator

128 channels. Graphically programmable sequences for inputs, outputs and bidirectional channels. Responses can be learnt, vectors can be saved, loaded and compared.

### Floating Digital Multimeter

2 auto-ranging channels. DC and AC volts measurements up to 400V. DC and AC current measurements up to 2A. Resistance measurement up to 20M. Statistics for minimum, maximum and average readings. Calculator for data processing and logging.

### Universal I/O

4 analogue channels and 4 digital channels. Analogue channels can output and measure voltages from -9V to +9V, as well as sinking and sourcing currents up to 20mA. Digital channels can output and read back TTL compatible logic levels.

### Short Locator

3 resistance ranges. Audible and visual indication of proximity to short. Audible continuity checker.

### Auxiliary Power Supply

5V output at 0.5A, +9V output at 100mA and -9V output at 100mA. Current monitoring on all three outputs.

### Variable Power Supply

2.5V to 6V variable logic supply with over voltage protection. Variable positive and negative supplies to 24V with variable current up to 1A.



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# Multiple Instrument Station Module

## Digital Storage Oscilloscope

### **Vertical**

Channels	2 + external trigger
Sampling rate	50MS/s (5GS/s ERS mode)
Bandwidth	> 100MHz
Coupling	AC, DC, GND
Input impedance	1M Ohm, 25pF
Vertical sensitivity	20mV to 2V per division
Vertical resolution	8 bits
Max. input voltage	100VDC

### **Horizontal**

Sweep speed	5ns/div to 5s/div
Memory	64kbytes/channel
Modes	normal, auto, single

### **Internal trigger**

Source	channel 1, channel 2, function generator
Slope	positive, negative
Sensitivity	< 0.5 divisions
Coupling	AC, DC, HF reject, LF reject

### **External trigger**

Input impedance	1M Ohm, 25pF
Slope	positive, negative
Sensitivity	< 10mV
Coupling	AC, DC, HF reject, LF reject
Max. input voltage	100V DC

### **Trigger delay**

Pre-trigger	0 to 100% of sweep time
Post-trigger	0 to 100% of sweep time

### **Measurements**

Automatic	standard waveform parameters
Comparison	time and voltage

## Function Generator

Waveforms	sine, square, triangle, single-shot pulse
Frequency range	0.1Hz to 10MHz, resolution 0.1% of range full scale
Pulse width	100ns to 10s
Modulation modes	AM, FM, PWM
Modulation frequency	400Hz internal
Duty cycle	20% to 80%, resolution 1%
Amplitude	0V to 5V, resolution 50mV
DC offset	-7.5V to 7.5V, resolution 50mV
Rise/fall time	25ns
Output impedance	50 Ohm

### **Sweep mode**

Start frequency	0.1Hz to 10MHz
End frequency	0.1Hz to 10MHz
Steps	1 to 1000
Time per step	0.1s to 9.9s

## Digital Floating Multimeter

Channels	2 channels
Input impedance	10M Ohm
Statistics	minimum, maximum, average

### **Channel 1**

Modes	DC volts, AC volts
Voltage range	0 to 400V
DC voltage resolution	0.005% full scale
DC voltage accuracy	+/-0.05%
AC voltage resolution	0.05% full scale
AC voltage accuracy	+/-0.1%

### **Channel 2**

Modes	DC volts, AC volts, DC current, AC current, resistance
Voltage range	0 to 400V
Current range	0 to 2A
Resistance range	0 to 20M Ohm
DC voltage resolution	0.005% full scale
DC voltage accuracy	+/-0.05%
AC voltage resolution	0.05% full scale
AC voltage accuracy	+/-0.1%
DC current resolution	1mA
DC current accuracy	+/-0.1%
AC current resolution	1mA
AC current accuracy	+/-0.2%
Resistance resolution	0.01% full scale
Resistance accuracy	+/-0.1%

## Auxiliary Power Supply

Output Voltages	+5V, +9V, -9V
Output Current	+5V supply - 500mA +9V supply - 100mA -9V supply - 100mA



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# Multiple Instrument Station (continued)

## Frequency Counter

Modes event, frequency, pulse width

### **Channel 1**

Impedance 50 Ohm  
Frequency range 1MHz to 150MHz  
Sensitivity < 5mV rms @ 2MHz to 10MHz  
< 15mV rms @ 10MHz to 100MHz  
Pulse response 50mV, 25ns pulse @ 500Hz  
Maximum input +/- 5V  
Basic accuracy +/- 0.02% +/- 1 count

### **Channel 2**

Impedance 1 MOhm  
Frequency range 2Hz to 100MHz  
Sensitivity < 300mV rms @ 10Hz  
< 150mV rms @ 10kHz to 10MHz  
< 350mV rms @ 33MHz  
Maximum input 200V rms  
Basic accuracy +/- 0.02% +/- 1 count

### **Event Mode**

Ch1 event count 0 to 9,999,999,999  
Ext gate width minimum 20ns  
Ext gate width time 6 hours, 10ms resolution  
10.74s, 5µs resolution  
84ms, 40ns resolution  
Statistics lowest, highest, average  
Display frequency, period, RPM events,  
pulse width, gate time

## Universal I/O

Number of channels 4 channels

### **Analogue Channels**

Modes voltage output, voltage input, current output,  
current input  
Voltage output range -9V to +9Vm resolution 10mV  
Voltage input range -10V to +10V, resolution 10mV  
Current output range 0 to +/-20mA, resolution µA

### **Digital Channels**

Modes logic output high, logic output low  
logic measurement  
Voltage TTL compatible logic levels

## Accessories

Output voltages 2 x DSO probes  
1 x yellow probe and cable  
1x blue probe and cable  
1x black probe and cable  
1x universal I/O cable (not terminated)

## Options

Internal fitting PCI Interface  
External fitting - MultiLink case (cost option) with USB  
- External case (cost option) which will hold up  
to 5 System8 modules (USB interface).

PC Requirements Pentium (1GHz) System  
Windows XP™  
20MB of free hard disk space  
256 MB RAM  
CD ROM Drive

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# 24 channel Analogue IC Tester Module

## V-I test capability

Number of test channels:	24 + 2 probes and references
Test voltage:	2 V to 50 V peak to peak
Voltage resolution:	8 to 12 bits
Test frequency:	37.5 Hz to 12 kHz
Test current:	1 $\mu$ A to 150 mA
Source impedance:	100 Ohm to 1 M
Test waveforms:	Sine, square, triangle, ramp, pulse
Waveform modes:	V-I, V-T, I-T
Waveform display:	Multi-plot with single waveform zoom
Waveform comparison:	Automatic comparison algorithm for good and bad boards using live probes or disk
V-I comparison tolerance:	50 mV to 500 mV with 50 mV resolution
Package support:	DIL, SOIC, PLCC, QFP and variants with MultiProbes
Pulse output:	Positive, negative or bipolar for thyristors/triacs
Pulse amplitude:	Adjustable to +/-10 V
Calibration:	Can be calibrated by user

## Analogue functional test capability

Number of I/O channels:	24 independent + 3 special discrete channels
Driver voltage:	-12 V to +12 V
Driver voltage resolution:	10 bit
Driver output current:	200 mA max sink or source
Driver states:	Voltage source, current source, off
Discrete source current:	10 $\mu$ A - 150 mA. (driving a load returned to 0 V)
Driver source impedance:	34 Ohm (34 Ohm, 1 k or 10 k on discrete channels)
Sensor input voltage:	+/- 24 V
Sensor voltage protection:	+/- 50 V
Sensor input impedance:	2 M
Sensor voltage resolution:	12 bit
Restrict voltage:	-10 V to +10 V
Restrict voltage resolution:	8 bit
Sensor current measurement:	1 mA to 150 mA (10 nA to 150 mA on discrete channels)
Sensor current resolution:	12 bit
Sensor current input impedance:	50 Ohm (50 Ohm, 1 k, 10 k or 1 M on discrete channels)
Short detection threshold:	<4 Ohm
Link detection threshold:	<10 Ohm
Test modes:	Single, unconditional loop, pass loop, fail loop
Test clip positioning:	Automatically adjusts for clip orientation
Circuit compensation:	Automatically modifies test for IC/PCB connections
Test trace:	Test waveforms and voltages displayed
Test analysis:	Displays test parameters such as gain, hfe, feedback
IC test capability:	Op-amps, comparators, DACs, ADCs, switches and special function analogue ICs in-circuit.
Discrete test capability:	Transistors, FETs, thyristors, triacs in- or out-of-circuit
IC test libraries:	Analogue, discrete, package, user
Result comparison:	Results can be saved for good/bad board comparison
Package support:	DIL, SOIC, PLCC and variants with MultiProbe kits
SLIM test programming:	Structured programming language for library additions

## Other specifications

Electrical input:	(typical) +12 V, 1 A(max) (typical) -5 V, 750 mA (typical) -12 V, 100 mA
Dimensions:	147 x 202 x 42 mm
Weight:	1 kg

## Accessories

Standard	1 x SMD test tweezer set and adapters 1 x 24 way test clip and cable assembly 1 x Blue V-I probes and adapter 1 x Yellow V-I probes and adapter 2 x Pulse leads 2 x Ground leads 3 x Discrete leads
----------	---

## Options

Internal fitting	PCI interface
External fitting	MultiLink case (cost option) with USB. External case (cost option) which can hold up to 5 SYSTEM 8 modules (USB interface).

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# 64 channel Board Fault Locator Module

## **Digital IC test capability**

Number of I/O channels:	64-256
Number of guard outputs:	4 or 8
Live comparison:	64 x 2, 128 x 2 with additional modules
Drive output voltage:	TTL/CMOS compatible
Drive output current:	Device dependent Typical H-L 80mA @ 0.6V Typical L-H 200mA @ 2V Max. 400mA
Drive slew rate:	>100V/ $\mu$ s
Receive input:	+/-10V
Input impedance:	10k
Termination:	Programmable for tri-state/open collector
Drive states:	Low, high, tri-state
Over voltage protection:	<0.5V, >5.5V
Test time:	Dependent on device
Circuit modes:	In-circuit. Out-of-circuit (with adapter)

## **Power supply for board under test**

Automatic power supply:	1 x 5V @ 5A fixed (2 x 5V @ 5A fixed for 128 channels)
Over voltage protection:	7V
Short circuit current:	7A

## **Test modes**

Single:	Single test
Loop:	Unconditional, loop while good, loop while bad
Auto:	Find tightest valid thresholds

## **Test thresholds**

Resolution:	100mV
Low levels:	TTL 0.1V to 1.1V CMOS 0.1V to 1.5V
Switching levels:	TTL 1.0V to 2.3V CMOS 1.0V to 3.0V
High levels:	TTL 1.9V to 4.9V CMOS 1.9V to 4.9V
Swept low levels:	TTL 0.1V to 1.1V CMOS 0.1V to 1.5V
Swept switching levels:	TTL 1.2V CMOS 2.5V
Swept high levels:	TTL 1.9V to 4.9V CMOS 1.9V to 4.9V

## **Test types**

Truth table (functional):	Library based functional test
Connections (MDA):	Short circuit detection Floating input detection Open circuit detection Linked pin detection
Voltage:	Resolution 10mV Range +/-10V Logic state detection
VI:	Number of channels 64 - 256 Sweep ranges -10V to +10V (programmable) Maximum test current 1mA Multi-plot with single waveform zoom
Thermal:	Indication of pin temperature

## **Test libraries**

Library classes:	TTL 54/74 logic, CMOS, Memory, Interface, LSI, Microprocessor, PAL/EPLD, Linear, Package, Special and user defined
Package types:	DIL, SOIC, PLCC, QFP

## **Accessories**

Standard	Automatic out-of-circuit adapter 1 x 64 way test cable 1 x 64 way split test cable 1 x V-I probe assembly 1 x BDO cable 1 x Short locator cable 1 x Ground clip 1 x PSU lead set
----------	---

## **Options**

Internal fitting	PCI interface
External fitting	MultiLink case (cost option) with USB. External case (cost option) which can hold up to 5 SYSTEM 8 modules (USB Interface).

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# Variable Power Supply Module

## **Logic Supply**

*Low voltage output for digital circuits*

Voltage	2.5V to 6V programmable
Resolution	0.01V
Over voltage	3V to 7V programmable threshold
Resolution	0.1V
Current	5A
Short circuit current	7A
Short circuit duration	indefinite (auto recovery)
Load regulation	0.5% (20% to 80% load change)
Ripple voltage	80mV pk-pk max

## **Variable Positive Supply**

*Positive voltage output for analogue circuits*

Voltage	0 to +24V programmable
Resolution	0.01V
Current	1.5A max
Over current limit	50mA to 1.5A programmable threshold
Short circuit current	1.5A
Short circuit duration	indefinite (auto recovery)
Load regulation	0.1% (20% to 80% load change)
Ripple voltage	50mV pk-pk max

## **Variable Negative Supply**

*Negative voltage output for analogue circuits*

Voltage	0 to -24V programmable
Resolution	0.01V
Current	1.5A max
Over current limit	50mA to 1.5A programmable threshold
Short circuit current	1.5A
Short circuit duration	indefinite (auto recovery)
Load regulation	0.1% (20% to 80% load change)
Ripple voltage	50mV pk-pk max

## **Physical data**

Weight	5kg
Size	295 x 247 x 65mm
Power rating	150W max
Connectors and cables	power cable, parallel interface cable, logic and ground cables, +V and -V cables
PC requirements	(Minimum) System capable of running Windows 95/98 with at least 32MB of RAM and 20MB of free hard disk space ECP/EPP capable parallel port or 16550 serial port

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# 24 channel Analogue Test Station Module

## **V-I test capability**

Number of test channels:	24 + 2 probes and references
Test voltage:	2 V to 50 V peak to peak
Voltage resolution:	8 to 12 bits
Test frequency:	37.5 Hz to 12 kHz
Test current:	1 $\mu$ A to 150 mA
Source impedance:	100 Ohm to 1 M
Test waveforms:	Sine, square, triangle, ramp, pulse
Waveform modes:	V-I, V-T, I-T
Waveform display:	Multi-plot with single waveform zoom
Waveform comparison:	Automatic comparison algorithm for good and bad boards using live probes or saved data
V-I comparison tolerance:	50 mV to 500 mV with 50 mV resolution
Package support:	DIL, SOIC, PLCC, QFP and variants with MultiProbes
Pulse output:	Positive, negative or bipolar for thyristors/triacs
Pulse amplitude:	Adjustable to +/-10 V
Calibration:	Automatic

## **Accessories**

Standard	1 x 24 way test cable 2 x Ground leads 2 x Pulse leads 1 x Blue V-I probe and adapter 1 x Yellow V-I probe and adapter 1 x SMD test tweezer set
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## **Options**

Internal fitting	PCI interface
External fitting	MultiLink case (cost option) with USB. External case (cost option) which can hold up to 5 SYSTEM 8 modules (USB Interface).

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# Training Board

## Board Fault Locator Functions

Digital Test:	Test types CCT conditions Loop testing Logic trace Thresholds Digital V-I Invalid conditions Grounding issues Tri-state testing Open collector testing Guarding Comparison tolerance Live comparison
Graphical Test Generator:	Configuring the graphical test generator Setting the thresholds Inputting waveforms Defining responses Auto-learning responses
IC identifier	Equivalent Functions Use of thresholds
Short locator:	Operation Ranges
EPROM verifier:	Loading and saving EPROM files Effect of bus shorts Use of BDO signals

## Analogue Test Station Functions

Analogue V-I:	Effect of varying voltage and impedance Effect of varying waveform Difference between VI, VT and IT tests Dual probe mode Storing test result Comparison tolerance Clip testing MultiProbe testing Probe compensation Matrix VI Use of pulse output Testing Relays
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## AICT Functions

Analogue functional test:	Test types Device conditions Supply range Test analysis box Loop testing Analogue trace Generic type versus part number
Discrete Testing:	Use of special channels Measuring gain and voltage Effect of parallel components

## Multiple Instrument Station Functions

Function generator:	Low frequency waveforms Higher frequency with duty cycle Changing wave shape, amplitude and offset Use of single pulse mode Effect of phase lock Effect of modulation Sweep mode
Frequency counter:	Measuring frequency/period Using event mode

DSO

Multimeter

MIS Power Supply

MIS Universal I/O

Setting target values  
Changing tolerances and display ranges  
Calculator  
Use of controls  
Acquisition modes  
Aliasing  
ERS mode  
Automatic measurements  
Waveform storing and comparison  
Adjusting comparison tolerances  
LM324 circuit  
Calculating op amp gain and DAC values  
Logging data  
Simple operation  
Simple discrete circuit (diode, transistor)  
Analogue output voltage and current  
Measuring voltage and current  
Testing transistors and diodes

## Electronic Principles Covered

Ohms Law  
R/L/C Circuits  
Diode Operation  
Transistor Operation  
MOSFET and FET Operation  
Op Amp Operation  
Comparator Operation

## Other specifications

Electrical input:

Powered by MIS power supply or via external 6-way Molex through-hole connector.

(typical) 5V, 600 mA (max)

(typical) +12V 100 mA

(typical) -12V, 100 mA

Dimensions:

209 x 165 x 19 mm

Weight:

222g

## Accessories

Standard

1 x power connector

1 x SYSTEM 8 Premier test flow files and manual

## Options

Cables:

3 x BNC cables for MIS

10-way cable for MIS

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